

Search Notes

Application/Control No.

10/045,810

Examiner

Erin M. File

Applicant(s)/Patent under
Reexamination

SEDAT OELCER

Art Unit

2634

SEARCHED

Class	Subclass	Date	Examiner
332	144	3/27/2005	EMF
370	215	3/27/2005	EMF
375	259	3/27/2005	EMF
375	260	3/27/2005	EMF
375	261	3/25/2005	EMF
375	298	3/27/2005	EMF
375	316	3/27/2005	EMF
455	110	3/27/2005	EMF

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST US PAT, USPGPUB, EPO, JPO DERWENT, IBM	3/25/2005	EMF
PALM INVENTORSHIP	3/25/2005	EMF
IEEE Keyword Search	3/25/2005	EMF